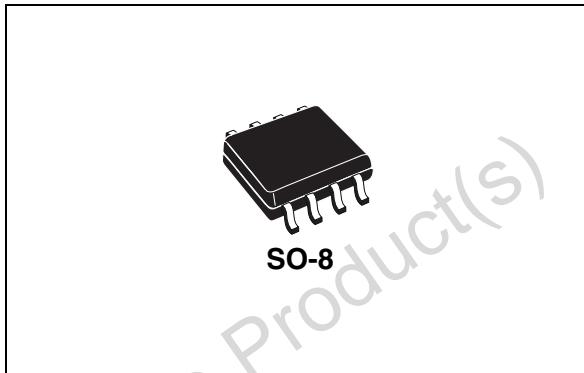


N-channel 150 V, 0.045  $\Omega$ , 5 A, SO-8  
STripFET<sup>TM</sup> III Power MOSFET

## Features

Type	V <sub>DSS</sub>	R <sub>DS(on)</sub> max	I <sub>D</sub>
STS5N15F3	150 V	< 0.057 $\Omega$	5 A

- Low on-resistance
- Low input capacitance and gate charge
- Low gate input resistance



## Application

- Switching applications

## Description

This product utilizes the latest advanced design rules of ST's proprietary STripFET<sup>TM</sup> technology which is suitable for the most demanding DC-DC converter applications where high efficiency is required.

Figure 1. Internal schematic diagram

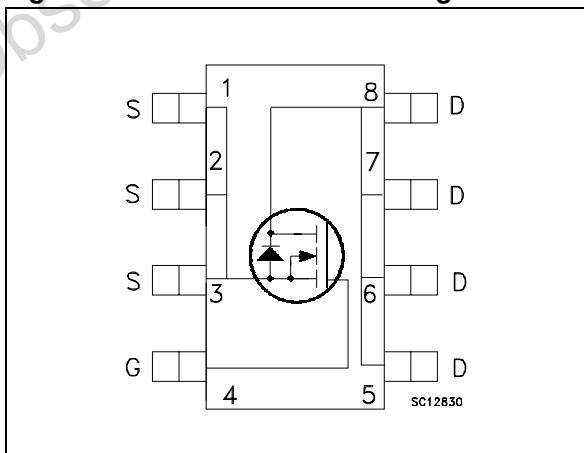


Table 1. Device summary

Order code	Marking	Package	Packaging
STS5N15F3	5F15-	SO-8	Tape and reel

## Contents

<b>1</b>	<b>Electrical ratings</b>	<b>3</b>
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Obsolete Product(s) - Obsolete Product(s)

# 1 Electrical ratings

**Table 2. Absolute maximum ratings**

Symbol	Parameter	Value	Unit
$V_{DS}$	Drain-source voltage ( $V_{GS} = 0$ )	150	V
$V_{GS}$	Gate-source voltage	$\pm 20$	V
$I_D$	Drain current (continuous) at $T_C = 25^\circ\text{C}$	5	A
$I_D$	Drain current (continuous) at $T_C = 100^\circ\text{C}$	3.2	A
$I_{DM}^{(1)}$	Drain current (pulsed)	20	A
$P_{TOT}$	Total dissipation at $T_C = 25^\circ\text{C}$	2.5	W
$T_{stg}$	Storage temperature	-55 to 150	$^\circ\text{C}$
$T_j$	Operating junction temperature		

1. Pulse width limited by safe operating area

**Table 3. Thermal data**

Symbol	Parameter	Value	Unit
$R_{thj-pcb}^{(1)}$	Thermal resistance junction-pcb max	50	$^\circ\text{C}/\text{W}$

1. When mounted on FR-4 board of 1 inch<sup>2</sup>, 2 oz Cu, t < 10 sec

**Table 4. Avalanche characteristics**

Symbol	Parameter	Max value	Unit
$I_{AS}$	Avalanche current, repetitive or not-repetitive (pulse width limited by $T_j$ max)	2.5	A
$E_{AS}$	Single pulse avalanche energy (starting $T_j = 25^\circ\text{C}$ , $I_D = I_{AS}$ , $V_{DD} = 140\text{ V}$ )	300	mJ

## 2 Electrical characteristics

( $T_J = 25^\circ\text{C}$  unless otherwise specified).

**Table 5. On/off states**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(\text{BR})\text{DSS}}$	Drain-source breakdown voltage	$I_D = 1 \text{ mA}, V_{GS} = 0$	150			V
$I_{\text{DSS}}$	Zero gate voltage drain current ( $V_{GS} = 0$ )	$V_{DS} = 150 \text{ V}$ , $V_{DS} = 150 \text{ V}, @ 125^\circ\text{C}$			1 10	$\mu\text{A}$ $\mu\text{A}$
$I_{GSS}$	Gate body leakage current ( $V_{DS} = 0$ )	$V_{GS} = \pm 20 \text{ V}$			$\pm 100$	nA
$V_{GS(\text{th})}$	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$	2		4	V
$R_{\text{DS(on)}}$	Static drain-source on resistance	$V_{GS} = 10 \text{ V}, I_D = 2.5 \text{ A}$		0.045	0.057	$\Omega$

**Table 6. Dynamic**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$C_{iss}$	Input capacitance			1300		pF
$C_{oss}$	Output capacitance	$V_{DS} = 25 \text{ V}, f = 1 \text{ MHz}$ ,	-	140	-	pF
$C_{rss}$	Reverse transfer capacitance	$V_{GS} = 0$		20.5		pF
$Q_g$	Total gate charge	$V_{DD} = 75 \text{ V}, I_D = 5 \text{ A}$		29		nC
$Q_{gs}$	Gate-source charge	$V_{GS} = 10 \text{ V}$	-	3.6	-	nC
$Q_{gd}$	Gate-drain charge	<i>Figure 14 on page 8</i>		14.6		nC
$R_g$	Gate input resistance	$f=1 \text{ MHz}$ Gate DC Bias=0 Test signal level=20 mV open drain	-	3.7	-	$\Omega$

**Table 7. Switching times**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{d(on)}$	Turn-on delay time			9		ns
$t_r$	Rise time			13		ns
$t_{d(off)}$	Turn-off delay time	$V_{DD} = 75 \text{ V}, I_D = 2.5 \text{ A}$ ,	-	46	-	ns
$t_f$	Fall time	$R_G = 4.7 \Omega, V_{GS} = 10 \text{ V}$ <i>Figure 13 on page 8</i>		20		ns

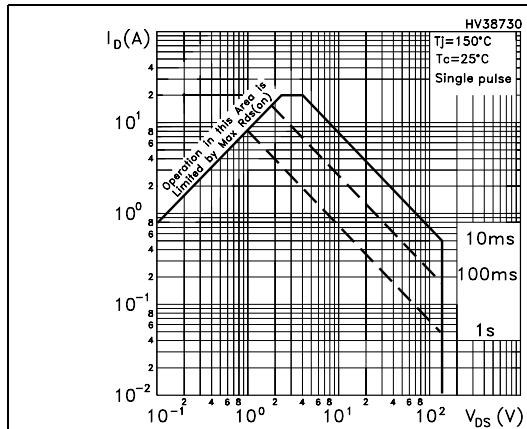
**Table 8. Source drain diode**

Symbol	Parameter	Test conditions	Min.	Typ.	Max	Unit
$I_{SD}$	Source-drain current		-		5	A
$I_{SDM}^{(1)}$	Source-drain current (pulsed)		-		20	A
$V_{SD}^{(2)}$	Forward on voltage	$I_{SD} = 5 \text{ A}, V_{GS} = 0$	-		1.3	V
$t_{rr}$ $Q_{rr}$ $I_{RRM}$	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_{SD} = 5 \text{ A},$ $di/dt = 100 \text{ A}/\mu\text{s},$ $V_R = 40 \text{ V}, T_J = 150 \text{ }^\circ\text{C}$ <i>Figure 15 on page 8</i>	-	110 498 9.1		ns nC A

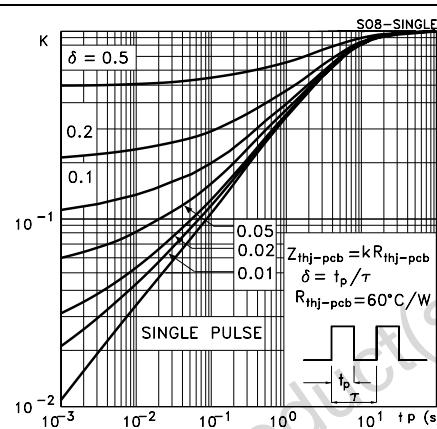
1. Pulse width limited by safe operating area.  
 2. Pulsed: pulse duration=300μs, duty cycle 1.5%

## 2.1 Electrical characteristics (curves)

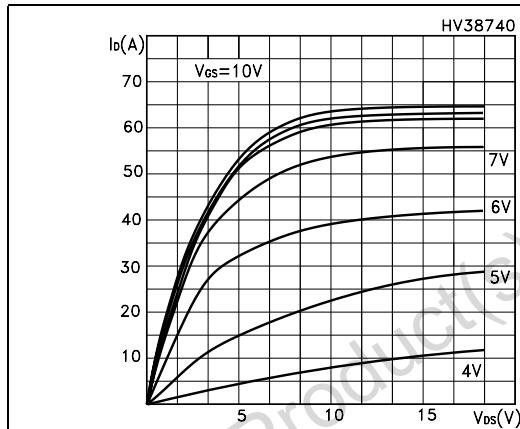
**Figure 2. Safe operating area**



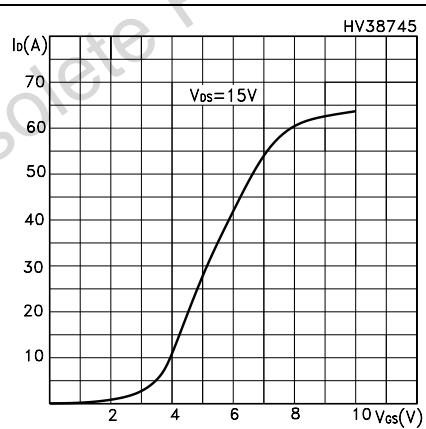
**Figure 3. Thermal impedance**



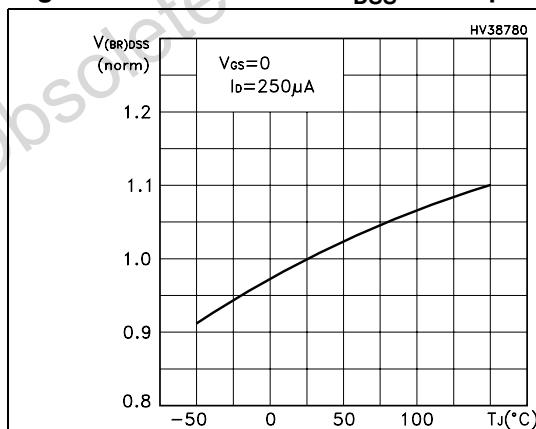
**Figure 4. Output characteristics**



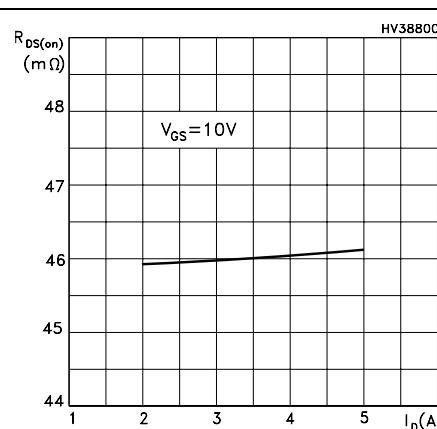
**Figure 5. Transfer characteristics**

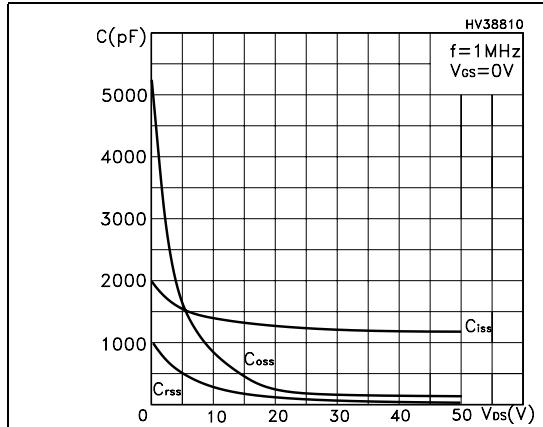
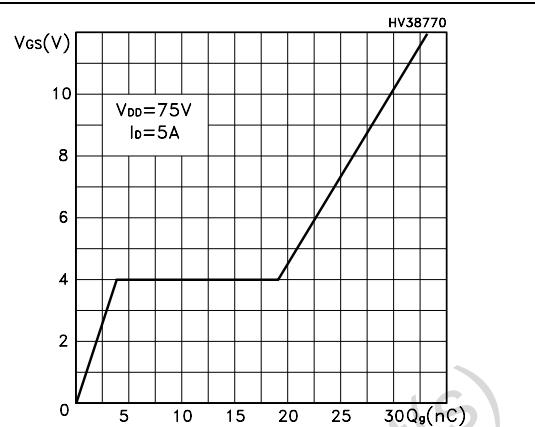
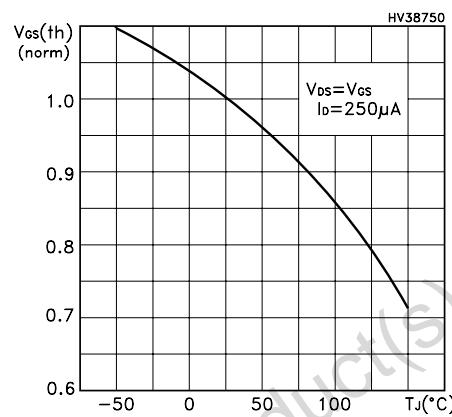
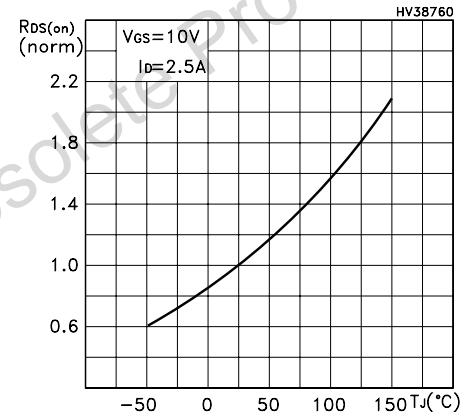
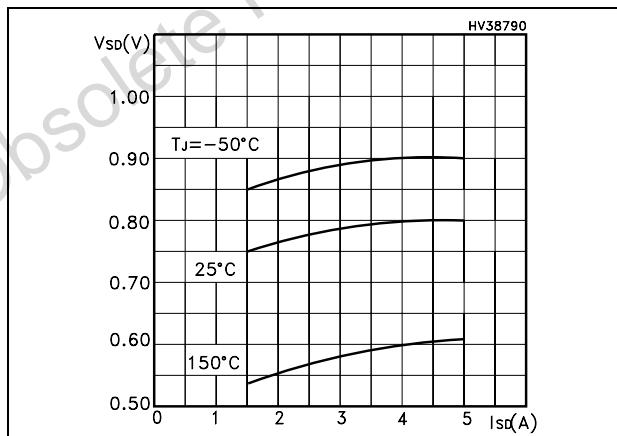


**Figure 6. Normalized  $BV_{DSS}$  vs temperature**



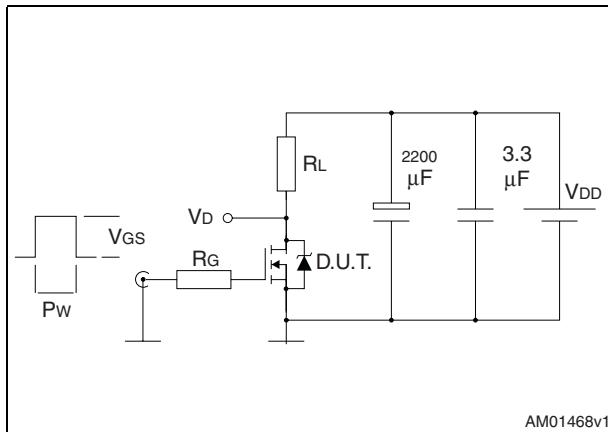
**Figure 7. Static drain-source on resistance**



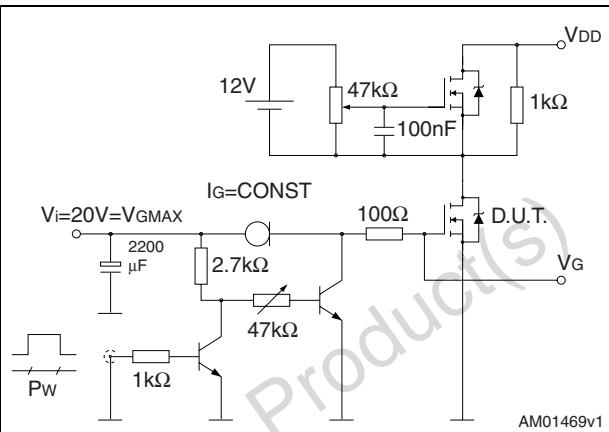
**Figure 8. Capacitance variations****Figure 9. Gate charge vs gate-source voltage****Figure 10. Normalized gate threshold voltage vs temperature****Figure 11. Normalized on resistance vs temperature****Figure 12. Source-drain diode forward characteristics**

### 3 Test circuit

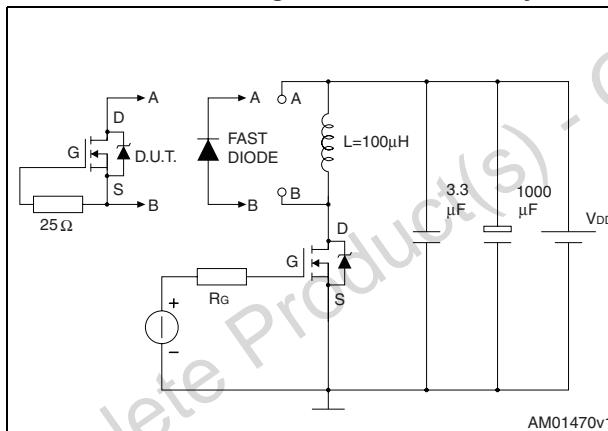
**Figure 13. Switching times test circuit for resistive load**



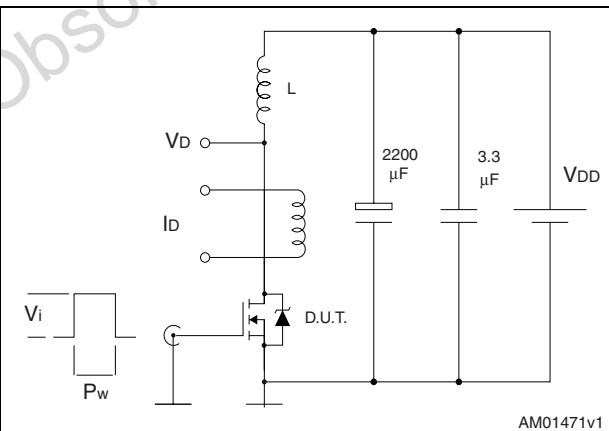
**Figure 14. Gate charge test circuit**



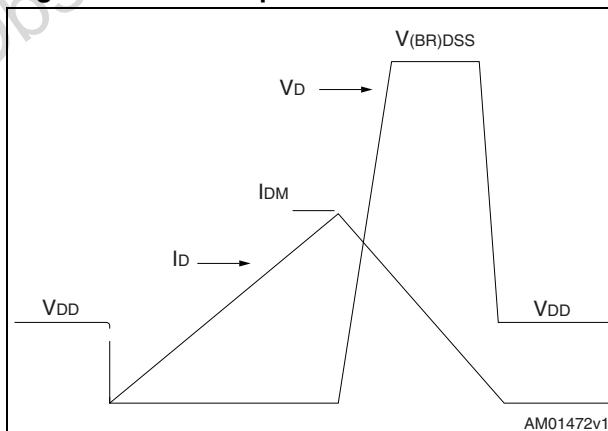
**Figure 15. Test circuit for inductive load switching and diode recovery times**



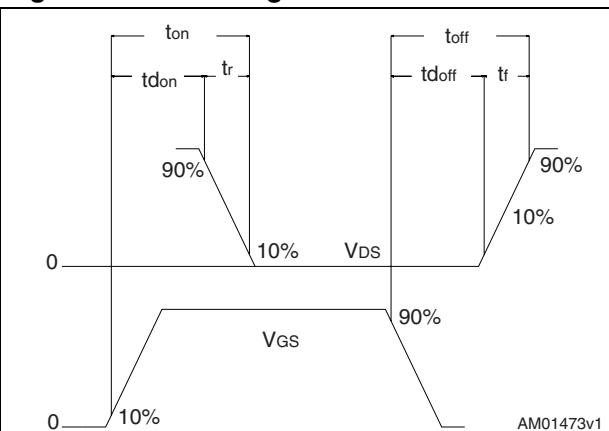
**Figure 16. Unclamped inductive load test circuit**



**Figure 17. Unclamped inductive waveform**



**Figure 18. Switching time waveform**



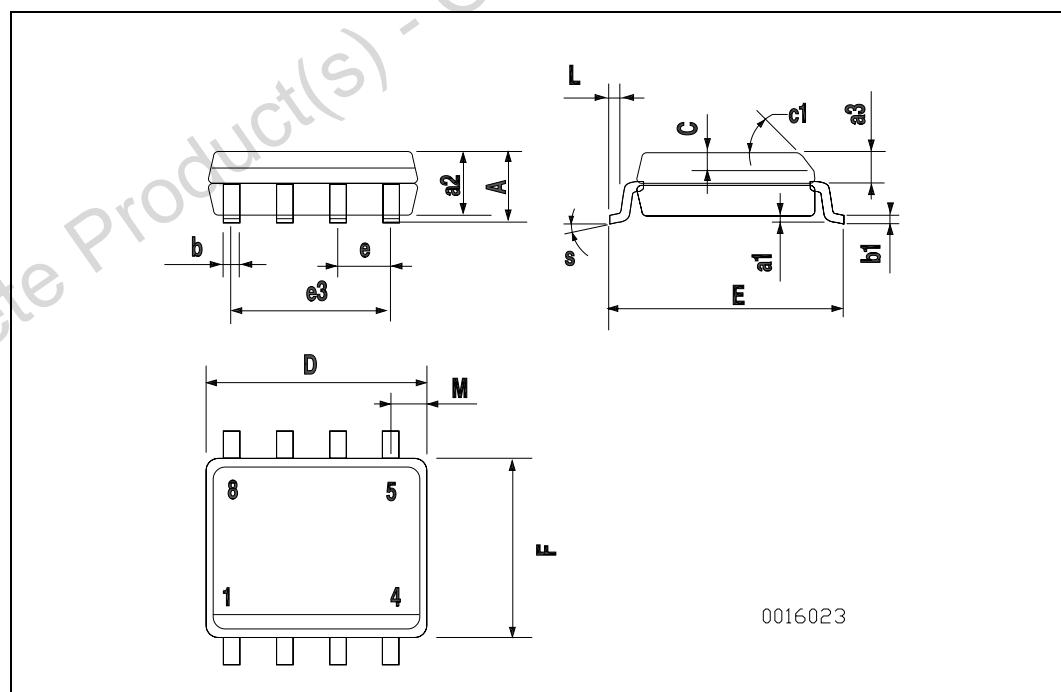
## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com). ECOPACK is an ST trademark.

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## SO-8 MECHANICAL DATA

DIM.	mm.			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
A			1.75			0.068
a1	0.1		0.25	0.003		0.009
a2			1.65			0.064
a3	0.65		0.85	0.025		0.033
b	0.35		0.48	0.013		0.018
b1	0.19		0.25	0.007		0.010
C	0.25		0.5	0.010		0.019
c1		45 (typ.)				
D	4.8		5.0	0.188		0.196
E	5.8		6.2	0.228		0.244
e		1.27			0.050	
e3		3.81			0.150	
F	3.8		4.0	0.14		0.157
L	0.4		1.27	0.015		0.050
M			0.6			0.023
S		8 (max.)				



## 5 Revision history

**Table 9. Document revision history**

Date	Revision	Changes
03-Mar-2009	1	First release
23-Aug-2010	2	Updated <a href="#">Table 1: Device summary</a> .

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